# **ON Semiconductor**

# Is Now



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# **Power MOSFET**

# 32 Amps, 60 Volts, N-Channel DPAK

Designed for low voltage, high speed switching applications in power supplies, converters and power motor controls and bridge circuits.

#### **Features**

- Pb-Free Packages are Available
- Smaller Package than MTB36N06V
- Lower R<sub>DS(on)</sub>
- Lower V<sub>DS(on)</sub>
- Lower Total Gate Charge
- Lower and Tighter V<sub>SD</sub>
- Lower Diode Reverse Recovery Time
- Lower Reverse Recovery Stored Charge

#### **Typical Applications**

- Power Supplies
- Converters
- Power Motor Controls
- Bridge Circuits

### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise noted)

Rating	Symbol	Value	Unit
Drain-to-Source Voltage	$V_{DSS}$	60	Vdc
Drain-to-Gate Voltage ( $R_{GS} = 10 \text{ M}\Omega$ )	$V_{DGR}$	60	Vdc
Gate-to-Source Voltage, Continuous	$V_{GS}$	±20	Vdc
<ul><li>Non–Repetitive (t<sub>p</sub>≤10 ms)</li></ul>	$V_{GS}$	±30	
Drain Current			
- Continuous @ T <sub>A</sub> = 25°C	I <sub>D</sub>	32	Adc
- Continuous @ T <sub>A</sub> = 100°C	, I <sub>D</sub>	22	
– Single Pulse (t <sub>p</sub> ≤10 μs)	I <sub>DM</sub>	90	Apk
Total Power Dissipation @ T <sub>A</sub> = 25°C	$P_{D}$	93.75	W
Derate above 25°C		0.625	W/°C
Total Power Dissipation @ T <sub>A</sub> = 25°C (Note 1)		2.88	W
Total Power Dissipation @ T <sub>A</sub> = 25°C (Note 2)		1.5	W
Operating and Storage Temperature Range	$T_J$ , $T_{stg}$	-55 to	°C
		+175	
Single Pulse Drain-to-Source Avalanche	E <sub>AS</sub>	313	mJ
Energy – Starting T <sub>J</sub> = 25°C (Note 3)			
$(V_{DD} = 50 \text{ Vdc}, V_{GS} = 10 \text{ Vdc}, L = 1.0 \text{ mH},$			
$I_{L(pk)} = 25 \text{ A}, V_{DS} = 60 \text{ Vdc}, R_G = 25 \Omega)$			
Thermal Resistance – Junction–to–Case	$R_{\theta JC}$	1.6	°C/W
<ul><li>– Junction–to–Ambient (Note 1)</li></ul>	$R_{\theta JA}$	52	
<ul><li>– Junction–to–Ambient (Note 2)</li></ul>	$R_{\theta JA}$	100	
Maximum Lead Temperature for Soldering	$T_L$	260	°C
Purposes, 1/8" from case for 10 seconds			

Maximum ratings are those values beyond which device damage can occur. Maximum ratings applied to the device are individual stress limit values (not normal operating conditions) and are not valid simultaneously. If these limits are exceeded, device functional operation is not implied, damage may occur and reliability may be affected.

- 1. When surface mounted to an FR4 board using 1" pad size, (Cu Area 1.127 in $^2$ ).
- When surface mounted to an FR4 board using minimum recommended pad size, (Cu Area 0.412 in<sup>2</sup>).
- 3. Repetitive rating; pulse width limited by maximum junction temperature.

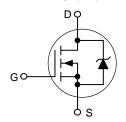


# ON Semiconductor®

#### http://onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> TYP	I <sub>D</sub> MAX
60 V	$26~\text{m}\Omega$	32 A

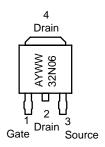
#### **N-Channel**

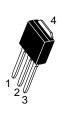


### MARKING DIAGRAMS

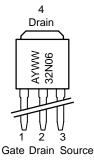


DPAK CASE 369C STYLE 2





DPAK-3 CASE 369D STYLE 2



32N06

= Device Code

A

Assembly LocationYear

WW

= Work Week

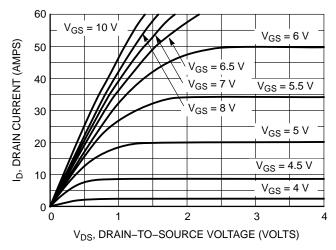
#### **ORDERING INFORMATION**

See detailed ordering and shipping information in the package dimensions section on page 6 of this data sheet.

# **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise noted)

DFF CHARACTERISTICS   Drain-to-Source Breakdown Voltage (Note 4) (V <sub>GS</sub> = 0 Vdc, I <sub>D</sub> = 25 Vdc, V <sub>GS</sub> = 0 Vd	Unit	Max	Тур	Min	Symbol	Characteristic		
(V <sub>SS</sub> = 0 Vdc, I <sub>D</sub> = 250 μAdc)   Temperature Coefficient (Positive)							OFF CHARACTERISTICS	
(V <sub>DS</sub> = 60 Vdc, V <sub>QS</sub> = 0 Vdc, T <sub>J</sub> = 150°C)         — — 1.0 10           Cate-Body Leakage Current (V <sub>QS</sub> = ±20 Vdc, V <sub>DS</sub> = 0 Vdc)         I <sub>QSS</sub> — — ±100           ON CHARACTERISTICS (Note 4)           Gate Threshold Voltage (Note 4)         V <sub>QS</sub> (th)         2.0 2.8 4.0           Threshold Temperature Coefficient (Negative)         2.0 2.8 4.0         4.0           Static Drain- to-Source On-Resistance (Note 4)         R <sub>DS(on)</sub> — 21 26           (V <sub>SS</sub> = 10 Vdc, I <sub>D</sub> = 16 Adc)         V <sub>DS(on)</sub> — 0.417 0.62           Static Drain-to-Source On-Voltage (Note 4)         V <sub>DS(on)</sub> — 0.417 0.62           (V <sub>QS</sub> = 10 Vdc, I <sub>D</sub> = 22 Adc)         — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680 — 0.680	Vdc mV/°C	_ _	-	60 -	V <sub>(BR)DSS</sub>	Drain-to-Source Breakdown Voltage (Note 4) (V <sub>GS</sub> = 0 Vdc, I <sub>D</sub> = 250 μAdc)		
ON CHARACTERISTICS (Note 4)   Gate Threshold Voltage (Note 4) (Vos = Vos Intershold Voltage (Note 4) (Vos = Vos Intershold Temperature Coefficient (Negative)   2.0	μAdc		- -	-	I <sub>DSS</sub>	Zero Gate Voltage Drain Current (V <sub>DS</sub> = 60 Vdc, V <sub>GS</sub> = 0 Vdc)		
Gate Threshold Voltage (Note 4)         VGS(th)         Z.0         2.8         4.0           Threshold Temperature Coefficient (Negative)         2.0         2.8         4.0           Threshold Temperature Coefficient (Negative)         RDS(on)         2.0         2.8         4.0           Static Drain-to-Source On-Resistance (Note 4)         RDS(on)         -         21         26           Static Drain-to-Source On-Voltage (Note 4)         VDS(on)         -         0.417         0.62           (VGS = 10 Vdc, Ip = 20 Adc)         -         0.680         -         0.680         -           (VGS = 10 Vdc, Ip = 32 Adc)         -         0.680         -         0.680         -           (VGS = 10 Vdc, Ip = 32 Adc)         -         0.680         -         0.680         -           Forward Transconductance (Note 4) (VDS = 6 Vdc, ID = 16 Adc)         FS         -         21.1         -           DYNAMIC CHARACTERISTICS           Input Capacitance         (VDS = 25 Vdc, VGS = 0 Vdc, ID = 32 Vdc, ID	nAdc	±100	_	-	I <sub>GSS</sub>	20 Vdc, V <sub>DS</sub> = 0 Vdc)	Gate-Body Leakage Current (V <sub>GS</sub> = ±2	
Vos = Vos							ON CHARACTERISTICS (Note 4)	
Comparison	Vdc mV/°C				V <sub>GS(th)</sub>	gative)	$(V_{DS} = V_{GS}, I_{D} = 250 \mu\text{Adc})$	
	mΩ	26	21	1	R <sub>DS(on)</sub>	e (Note 4)		
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Vdc	-	0.680	-	V <sub>DS(on)</sub>	$(V_{GS} = 10 \text{ Vdc}, I_D = 20 \text{ Adc})$ $(V_{GS} = 10 \text{ Vdc}, I_D = 32 \text{ Adc})$		
	mhos	_	21.1	-	9FS	Forward Transconductance (Note 4) (V <sub>DS</sub> = 6 Vdc, I <sub>D</sub> = 16 Adc)		
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$							DYNAMIC CHARACTERISTICS	
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	pF	1725	1231	-	C <sub>iss</sub>		Input Capacitance	
		485	346	_	C <sub>oss</sub>		Output Capacitance	
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$		160	77	_	C <sub>rss</sub>	]	Transfer Capacitance	
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$						e 5)	SWITCHING CHARACTERISTICS (Note	
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	ns	25	10	-	t <sub>d(on)</sub>		Turn-On Delay Time	
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$		180	84	-	t <sub>r</sub>		Rise Time	
		70	31	-	t <sub>d(off)</sub>		Turn-Off Delay Time	
$ (V_{DS} = 48 \text{ Vdc}, I_{D} = 32 \text{ Adc}, \\ V_{GS} = 10 \text{ Vdc}) \text{ (Note 4)} $ $ Q_{1}                                    $		200	93	_	t <sub>f</sub>		Fall Time	
$V_{GS} = 10 \text{ Vdc}) \text{ (Note 4)} \qquad \qquad Q_1 \qquad - \qquad 6.0 \qquad - \qquad \\ Q_2 \qquad - \qquad 15 \qquad - \qquad \\ \textbf{SOURCE-DRAIN DIODE CHARACTERISTICS}$ Forward On–Voltage $ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	nC	60	33	_	Q <sub>T</sub>		Gate Charge	
		_	6.0	-	Q <sub>1</sub>	. 50		
Forward On–Voltage $(I_S = 20 \text{ Adc}, V_{GS} = 0 \text{ Vdc}) \text{ (Note 4)} $ $V_{SD}$ $-$ 0.89 1.0 $(I_S = 32 \text{ Adc}, V_{GS} = 0 \text{ Vdc}) \text{ (Note 4)} $ $-$ 0.96 $-$		-	15	-	$Q_2$			
$(I_S = 32 \text{ Adc}, V_{GS} = 0 \text{ Vdc}) \text{ (Note 4)}$ - 0.96 -						ISTICS	SOURCE-DRAIN DIODE CHARACTER	
	Vdc	-	0.96	- - -	$V_{SD}$	$(I_S = 32 \text{ Adc}, V_{GS} = 0 \text{ Vdc}) \text{ (Note 4)}$	Forward On–Voltage	
Reverse Recovery Time t <sub>rr</sub> – 52 –	ns	_	52	-	t <sub>rr</sub>		Reverse Recovery Time	
$(I_S = 32 \text{ Adc, V}_{GS} = 0 \text{ Vdc,} \\ dI_S/dt = 100 \text{ A/}\mu\text{s) (Note 4)} $ $t_a$ $-$ 37 $-$		_	37	_	ta			
t <sub>b</sub> - 14.3 -		-	14.3	-	t <sub>b</sub>	α.5 α. – 100 / γμο) (11010 4)		
Reverse Recovery Stored Charge Q <sub>RR</sub> - 0.095 -	μС	_	0.095	-	Q <sub>RR</sub>	,	Reverse Recovery Stored Charge	

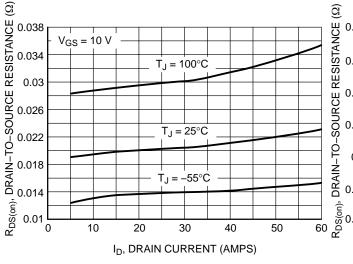
Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.



60  $V_{DS} > = 10 \text{ V}$ l<sub>D</sub>, DRAIN CURRENT (AMPS)  $T_J = 25^{\circ}C$  $T_J = 100^{\circ}C$ = -55°C 0 3.4 3.8 4.2 4.6 5 5.4 5.8 6.2 3 V<sub>GS</sub>, GATE-TO-SOURCE VOLTAGE (VOLTS)

Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics



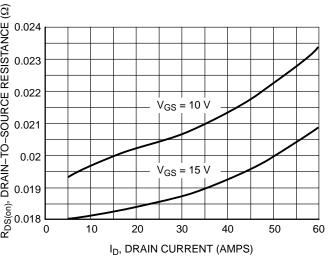
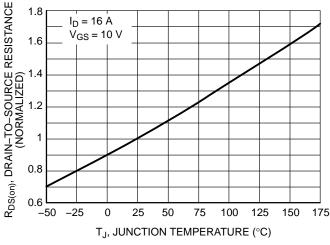


Figure 3. On-Resistance vs. Gate-to-Source Voltage

Figure 4. On-Resistance vs. Drain Current and Gate Voltage



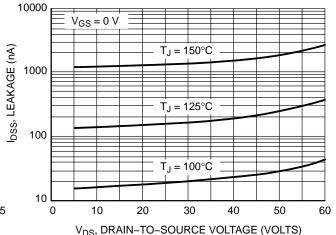


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Voltage

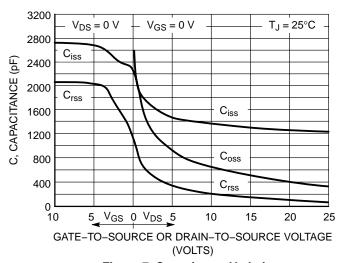


Figure 7. Capacitance Variation

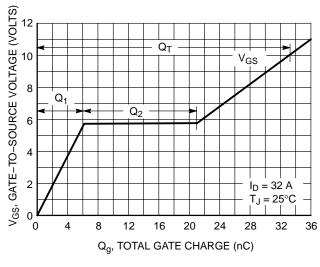


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

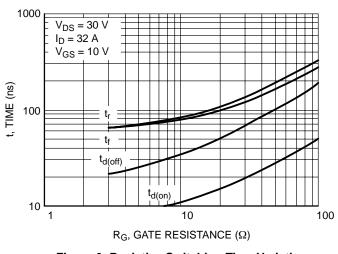


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

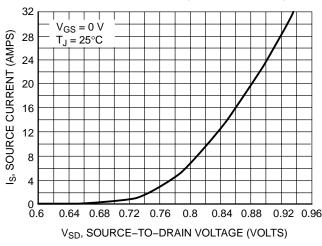


Figure 10. Diode Forward Voltage vs. Current

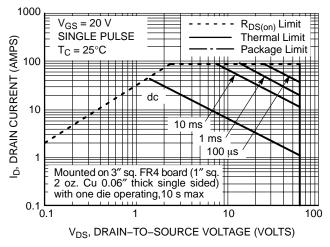


Figure 11. Maximum Rated Forward Biased Safe Operating Area

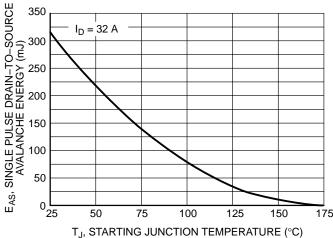


Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

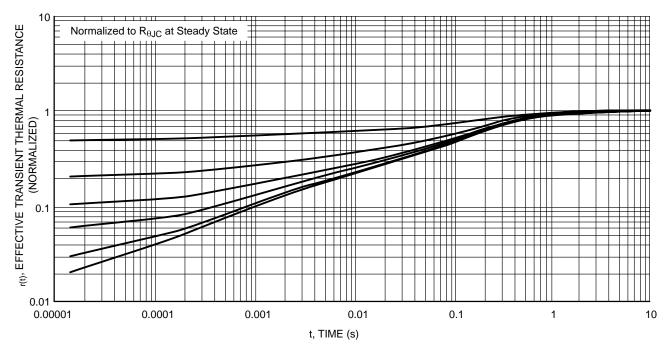


Figure 13. Thermal Response

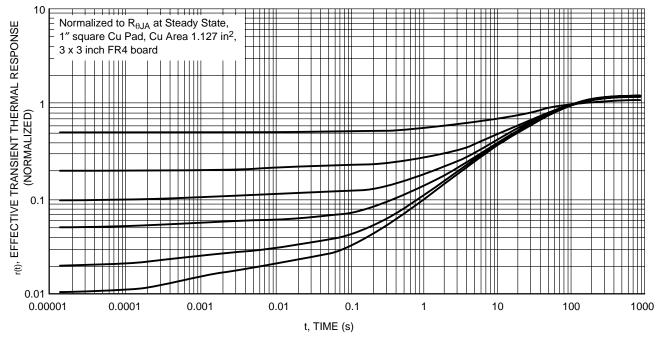


Figure 14. Thermal Response

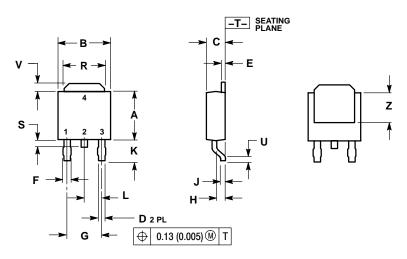
#### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NTD32N06	DPAK	75 Units/Rail
NTD32N06G	DPAK (Pb-Free)	75 Units/Rail
NTD32N06-1	DPAK-3	75 Units/Rail
NTD32N06-1G	DPAK-3 (Pb-Free)	75 Units/Rail
NTD32N06T4	DPAK	2500 Tape & Reel
NTD32N06T4G	DPAK (Pb-Free)	2500 Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

# **PACKAGE DIMENSIONS**

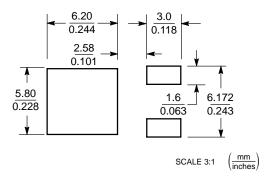
### **DPAK** CASE 369C-01 ISSUE O



	INCHES		MILLIN	ETERS
DIM	MIN	MAX	MIN	MAX
Α	0.235	0.245	5.97	6.22
В	0.250	0.265	6.35	6.73
С	0.086	0.094	2.19	2.38
D	0.027	0.035	0.69	0.88
E	0.018	0.023	0.46	0.58
F	0.037	0.045	0.94	1.14
G	0.180 BSC		4.58 BSC	
Н	0.034	0.040	0.87	1.01
J	0.018	0.023	0.46	0.58
K	0.102	0.114	2.60	2.89
L	0.090 BSC		2.29 BSC	
R	0.180	0.215	4.57	5.45
S	0.025	0.040	0.63	1.01
U	0.020		0.51	
٧	0.035	0.050	0.89	1.27
Z	0.155		3.93	

STYLE 2: PIN 1. GATE 2. DRAIN 3. SOURCE 4. DRAIN

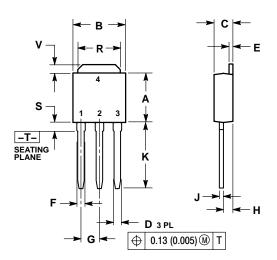
# **SOLDERING FOOTPRINT\***

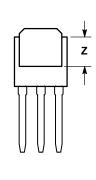


\*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

#### PACKAGE DIMENSIONS

DPAK-3 CASE 369D-01 ISSUE B





- NOTES:
  1. DIMENSIONING AND TOLERANCING PER
- ANSI Y14.5M, 1982.
  2. CONTROLLING DIMENSION: INCH.

	INCHES		MILLIN	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.235	0.245	5.97	6.35
В	0.250	0.265	6.35	6.73
С	0.086	0.094	2.19	2.38
D	0.027	0.035	0.69	0.88
Е	0.018	0.023	0.46	0.58
F	0.037	0.045	0.94	1.14
G	0.090 BSC		2.29 BSC	
Н	0.034	0.040	0.87	1.01
J	0.018	0.023	0.46	0.58
K	0.350	0.380	8.89	9.65
R	0.180	0.215	4.45	5.45
S	0.025	0.040	0.63	1.01
٧	0.035	0.050	0.89	1.27
Z	0.155		3.93	

STYLE 2: PIN 1. GATE

- 2. DRAIN
- 3 SOURCE
- DRAIN

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